



Features

- Advanced Process Technology
- Dual N-Channel MOSFET
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- · Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

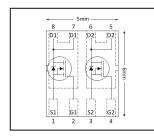
Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this product an extremely efficient and reliable device for use in Automotive and wide variety of other applications.

Applications

- 12V Automotive Systems
- Low Power Brushed Motor
- Braking

V _{DSS}	40V
R _{DS(on)} typ.	8.0 m Ω
max	10m Ω
I _D (@Τ _{C (Bottom)} = 25°C	43A





G	D	S
Gate	Drain	Source

Base Part Number	Package Type	Standard	Orderable Part Number	
		Form	Quantity	
AUIRFN8458	Dual PQFN 5mm x 6mm	Tape and Reel	4000	AUIRFN8458TR

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
I _D @ T _{C (Bottom)} = 25°C	Continuous Drain Current, V _{GS} @ 10V	43	
$I_D @ T_{C (Bottom)} = 100^{\circ}C$	Continuous Drain Current, V _{GS} @ 10V	30	Α
I _{DM}	Pulsed Drain Current ①	180	
$P_D @T_{C (Bottom)} = 25^{\circ}C$	Power Dissipation	34	W
	Linear Derating Factor	0.23	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②	35	mJ
E _{AS} (Tested)	Single Pulse Avalanche Energy ®	37	
I _{AR}	Avalanche Current ①	See Fig. 14, 15, 22a, 22b	Α
E _{AR}	Repetitive Avalanche Energy ①		
TJ	Operating Junction and	-55 to + 175	°C
T _{STG}	Storage Temperature Range		C

HEXFET® is a registered trademark of International Rectifier.

^{*}Qualification standards can be found at http://www.irf.com/



Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
R _{0JC} (Bottom)	Junction-to-Case ®		4.4	
R _{θJC} (Top)	Junction-to-Case ®		50	°C/\\/
$R_{\theta JA}$	Junction-to-Ambient ⑦		105	°C/W
R _{θJA} (<10s)	Junction-to-Ambient ⑦		82	

Static Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	40			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		37		mV/°C	Reference to 25 $^{\circ}$ C, I_D = 1.0mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		8.0	10	mΩ	$V_{GS} = 10V, I_D = 26A$
$V_{GS(th)}$	Gate Threshold Voltage	2.2		3.9	V	$V_{DS} = V_{GS}$, $I_D = 25\mu A$
gfs	Forward Transconductance	56			S	$V_{DS} = 10V, I_D = 26A$
R_G	Internal Gate Resistance		1.9		Ω	
	Drain to Course Leakage Current			1.0		$V_{DS} = 40V, V_{GS} = 0V$
I _{DSS}	Drain-to-Source Leakage Current			150	μA	$V_{DS} = 40V$, $V_{GS} = 0V$, $T_{J} = 125$ °C
I _{GSS}	Gate-to-Source Forward Leakage			100	n 1	V _{GS} = 20V
	Gate-to-Source Reverse Leakage			-100	nA	$V_{GS} = -20V$

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Q_g	Total Gate Charge		22	33		I _D = 26A
Q_{gs}	Gate-to-Source Charge		6.3			$V_{DS} = 20V$
Q_{gd}	Gate-to-Drain ("Miller") Charge		7.6		nC	V _{GS} = 10V
Q _{sync}	Total Gate Charge Sync. (Q _g - Q _{gd})		14.4			I _D = 26A, V _{DS} =0V, V _{GS} = 10V
$t_{d(on)}$	Turn-On Delay Time		9.7			V _{DD} = 26V
t _r	Rise Time		71			I _D = 26A
$t_{d(off)}$	Turn-Off Delay Time		11		ns	$R_G = 2.7\Omega$
t _f	Fall Time		19			V _{GS} = 10V ④
C _{iss}	Input Capacitance		1060			$V_{GS} = 0V$
Coss	Output Capacitance		170			V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance		100		pF	f = 1.0 MHz
Coss eff. (ER)	Effective Output Capacitance (Energy Related)		210			V _{GS} = 0V, V _{DS} = 0V to 32V ⑥
C _{oss} eff. (TR)	Effective Output Capacitance (Time Related)		250			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 32V $

Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
	Continuous Source Current			43	^	MOSFET symbol
IS	(Body Diode)	showing the				
	Pulsed Source Current			180	^	integral reverse
ISM	(Body Diode) ①				Α	p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C$, $I_S = 26A$, $V_{GS} = 0V$ ④
dv/dt	Peak Diode Recovery		8.2		V/ns	$T_J = 175$ °C, $I_S = 26A$, $V_{DS} = 40V$ 3
4	Poverse Becovery Time		18			$T_J = 25^{\circ}C$
t _{rr}	Reverse Recovery Time		19		ns	$T_J = 125^{\circ}C$ $V_R = 34V$,
0	Doverse Becovery Charge		9.6		nC	$T_J = 25^{\circ}C$ $I_F = 26A$
Q_{rr}	Reverse Recovery Charge		11		IIC	$T_{J} = 125^{\circ}C$ di/dt = 100A/µs4
I _{RRM}	Reverse Recovery Current		0.89		Α	T _J = 25°C



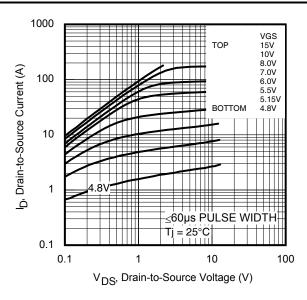


Fig. 1 Typical Output Characteristics

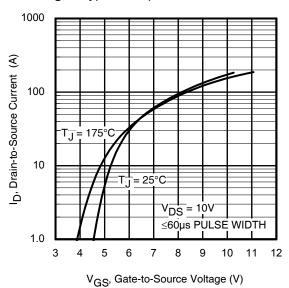


Fig. 3 Typical Transfer Characteristics

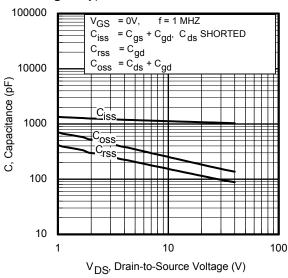


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

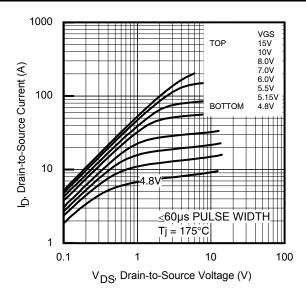


Fig. 2 Typical Output Characteristics

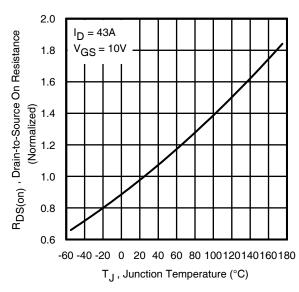


Fig. 4 Normalized On-Resistance vs. Temperature

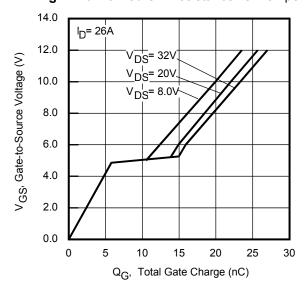
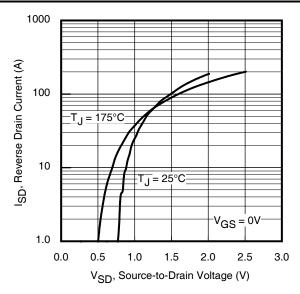


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage





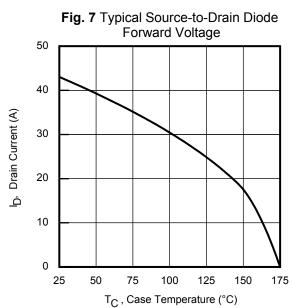


Fig 9. Maximum Drain Current vs. Case Temperature

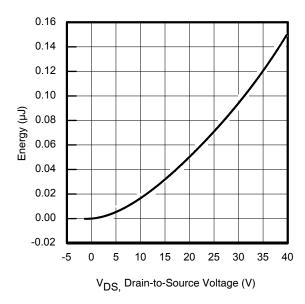


Fig 11. Typical Coss Stored Energy

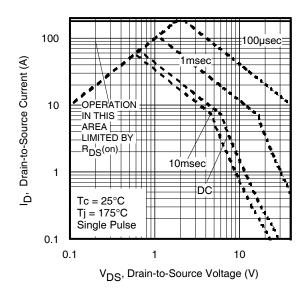


Fig 8. Maximum Safe Operating Area

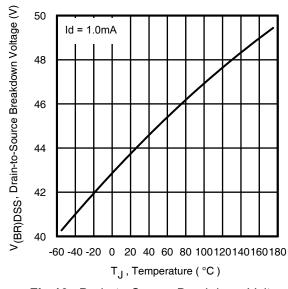


Fig 10. Drain-to-Source Breakdown Voltage

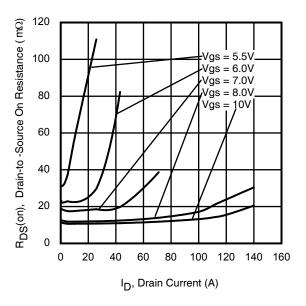


Fig 12. Typical On-Resistance vs. Drain Current



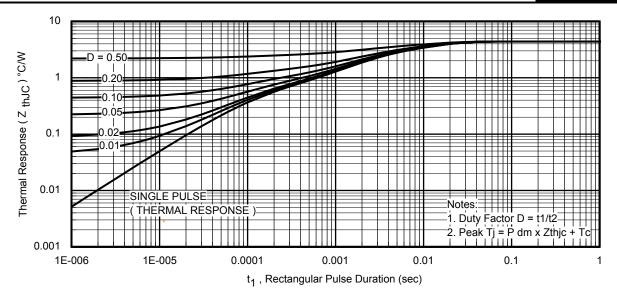


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

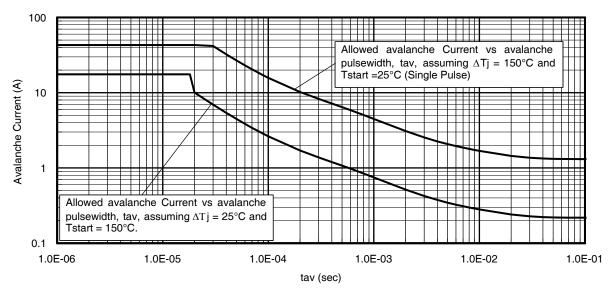


Fig 14. Typical Avalanche Current vs. Pulse Width

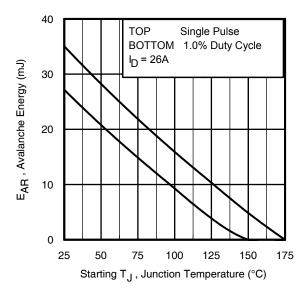


Fig 15. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

excess of T_{jmax}. This is validated for every part type.

- Avalanche failures assumption:
 Purely a thermal phenomenon and failure occurs at a temperature far in
- 2. Safe operation in Avalanche is allowed as long as Tjmax is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).
 - tav = Average time in avalanche.
 - D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \text{ (ave)}} = 1/2 \text{ (} 1.3 \cdot \text{BV} \cdot \text{I}_{av} \text{)} &= \Delta \text{T} \text{/ } Z_{thJC} \\ I_{av} = 2\Delta \text{T} \text{/ } [1.3 \cdot \text{BV} \cdot Z_{th}] \\ E_{AS \text{ (AR)}} = P_{D \text{ (ave)}} \cdot t_{av} \end{split}$$



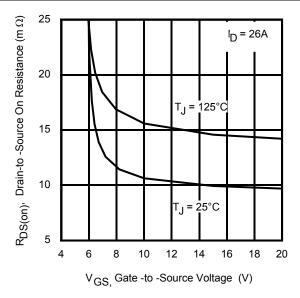


Fig 16. Typical On-Resistance vs. Gate Voltage

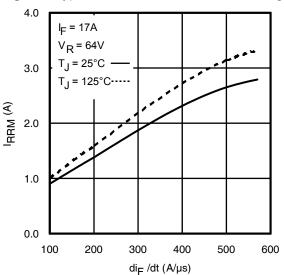


Fig. 18 - Typical Recovery Current vs. dif/dt

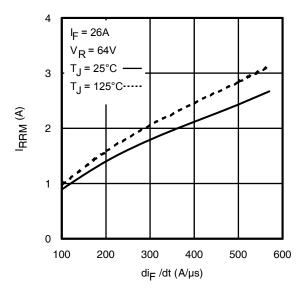


Fig. 20 - Typical Recovery Current vs. dif/dt

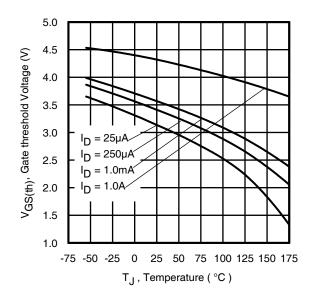


Fig 17. Threshold Voltage vs. Temperature

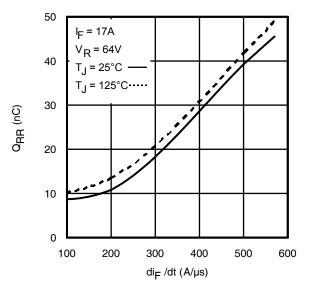


Fig. 19 - Typical Stored Charge vs. dif/dt

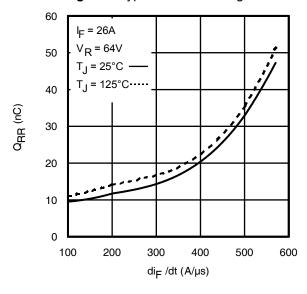


Fig. 21 - Typical Stored Charge vs. dif/dt



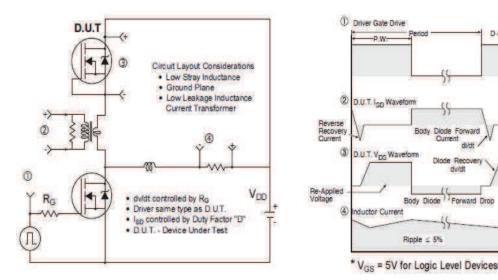


Fig 22. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

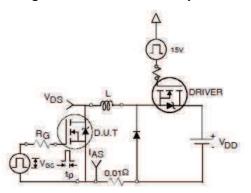


Fig 22a. Unclamped Inductive Test Circuit

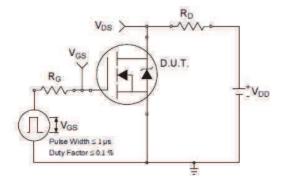


Fig 23a. Switching Time Test Circuit

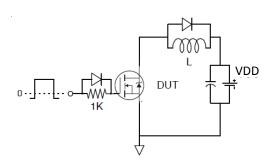


Fig 24a. Gate Charge Test Circuit

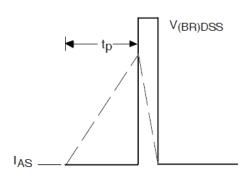


Fig 22b. Unclamped Inductive Waveforms

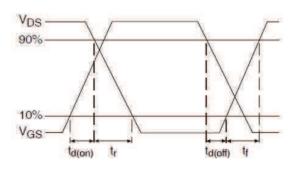


Fig 23b. Switching Time Waveforms

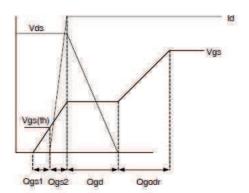
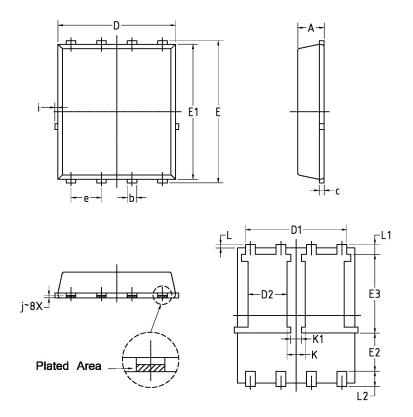


Fig 24b. Gate Charge Waveform



Dual PQFN 5x6 Package Details

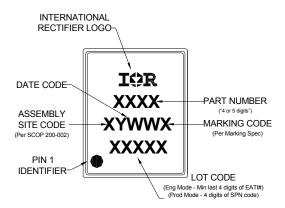


S Y	COMMON				
M B O	М	MM		ΞH	
O L	MIN.	MAX.	MIN.	MAX.	
Α	1.00	1.20	0.039	0.047	
ь	0.30	0.50	0.012	0.020	
С	0.203	BSC	0.008	BSC	
D	4.80	5.00	0.189	0.197	
D1	4.06	4.36	0.160	0.172	
D2	1.47	1.77	0.058	0.070	
Ε	5.90	6.20	0.232	0.244	
E1	5.65	5.85	0.222	0.230	
E2	1.45	_	0.057	_	
E3	3.20	3.50	0.126	0.138	
е	1.27	BSC	0.05 BSC		
L	0.05	0.25	0.002	0.010	
L1	0.325	0.525	0.013	0.021	
L2	0.500	0.800	0.020	0.031	
i	_	0.20	_	0.008	
K	0.61	0.91	0.024	0.036	
K1	0.31	0.60	0.012	0.024	
j	0.1015	BSC	0.004	4BSC	

For more information on board mounting, including footprint and stencil recommendation, please refer to application note AN-1136: http://www.irf.com/technical-info/appnotes/an-1136.pdf

For more information on package inspection techniques, please refer to application note AN-1154: http://www.irf.com/technical-info/appnotes/an-1154.pdf

Dual PQFN 5x6 Part Marking



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information[†]

Qualification	ii iiiioiiiialioii				
		Automotive (per AEC-Q101)			
Qualification Level Comments: This part number(s) passed Automotive qualification. dustrial and Consumer qualification level is granted by extension of er Automotive level.					
Moisture Sensi	tivity Level	Dual PQFN 5mm x 6mm MSL1			
	Human Body Model	Class H1A (+/- 500V) ^{††}			
			AEC-Q101-001		
ESD	Charged Device Model	Class C5 (+/- 1000V) ^{††}			
		AEC-Q101-005			
RoHS Complia	ant	Yes			

- † Qualification standards can be found at International Rectifier's web site: http://www.irf.com/
- †† Highest passing voltage.

Notes:

- $\ensuremath{\mathbb{O}}$ Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by T_{Jmax} , starting T_J = 25°C, L =110 μ H, R_G = 50 Ω , I_{AS} = 50A, V_{GS} = 10V.
- $\exists \quad I_{SD} \leq 50 A, \ di/dt \leq 650 A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175 ^{\circ}C.$
- 4 Pulse width $\leq 400 \mu s$; duty cycle $\leq 2\%$.
- © C_{oss eff. (TR)} is a fixed capacitance that gives the same charging time as Coss while V_{DS} is rising from 0 to 80% V_{DSS}.
- © $C_{oss\ eff.\ (ER)}$ is a fixed capacitance that gives the same energy as Coss while V_{DS} is rising from 0 to 80% V_{DSS} .
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994: http://www.irf.com/technical-info/appnotes/an-994.pdf
- \otimes R₀ is measured at T_J of approximately 90°C.
- \odot This value determined from sample failure population, starting T_J = 25°C, L= 110 μ H, R_G = 50 Ω , I_{AS} = 50A, V_{GS} =10V.



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http://www.irf.com/technical-info/

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